



Metrics NA TC Chapter

Wednesday, October 26, 2022

Via Web Conference

2:00 PM–5:00 PM (Pacific Time)

AGENDA

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| | Time |
| 1 Welcome/Call to Order | 2:00-2:05 |
| 1.1 Introductions | |
| 1.2 Required Meeting Elements (Membership Requirements, Antitrust and Intellectual Property Reminders, and Effective Meeting Guidelines) | |
| 1.3 Agenda Review | |

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| 2 Review of Previous Meeting Minutes (including open Action Items review) | 2:05-2:10 |
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| 3 Staff Report | 2:10-2:25 |
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| 4 Liaison Reports | 2:25-2:30 |
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- 4.1 Japan TC Chapter

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| 5 Ballot Review (including safety and IP checks) | 2:30-4:00 |
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#	When	TF	Details
6971	Cycle 7-2022	ESD/ESC Task Force	Revision of SEMI E163-0212 (Reapproved 1217) With Title Change To: Guide for the Handling of Extremely Electrostatic Sensitive (EES) Items Within Specially Designated Areas

6 Subcommittee & Task Force Reports

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| 6.1 ESD/ESC Task Force – Chuck McClain / Viraj Pandit | 4:00-4:30 |
| 6.2 EMC Task Force – Vladimir Kraz / Mark Frankfurth | |
| 6.3 RF Measurements Task Force – Supika Mashiro | |
| 6.4 Equipment RAMP Metrics Task Force – Steven Meyer / Todor Ganev | |
| 6.5 Critical Chamber Components (CCC) Test Methods Task Force – Michael Cox / Supika Mashiro | |



7 Old Business **4:30-4:35**

- 7.1 Standards due for Five-Year Review
- 7.2 SNARFs approaching Three-Year Document Development Project Period

8 New Business **4:35-4:40**

- 8.1 New TFOFs & SNARFs
- 8.2 New Ballot(s) Submission Summary
- 8.3 ESDA TFOF

9 New Action Item Review **4:40-4:45**

10 Next Meetings Schedule (TBD) **4:45-4:50**

Date/Time/Location

- ESD/ESC Task Force
- EMC Task Force
- RF Measurements Task Force
- Equipment RAMP Metrics Task Force
- Critical Chamber Components (CCC) Test Methods Task Force

11 Adjournment **4:50**

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